# Short-Circuit Diffusion in Crystals

3.205 L6 11/14/06

Today's topics:

- Diffusion spectrum in defective crystals
- Dislocation core structure and dislocation "short circuits"
- Grain boundary structure
- Grain boundary diffusion mechanisms and phenomena
- Some phenomena where short-circuits are important

#### Diffusion Paths in Polycrystals

- *D*<sup>xL</sup>, bulk (lattice) diffusivity
- *D*<sup>B</sup>, grain boundary diffusivity
- *D*<sup>s</sup>, (free) surface diffusivity
- *D*<sup>*D*</sup>, dislocation diffusivity





#### Grain Boundary Diffusion in NiO

Diffusion data from NiO, comparing rates of bulk diffusion and grain boundary diffusion



## Dislocation "Pipe" Diffusion

Dislocations, especially edge dislocations, can act as shortcircuit diffusion paths.

Dissociated dislocations have cores that are more spread out, connected by a ribbon of stacking fault:



#### Grain Boundary Structure

Specification of a grain boundary: five degrees of freedom (at least)

Rotation axis  $\hat{r}$ 

Rotation angle  $\theta$ 

Boundary normal  $\hat{n}$ 

Example: tilt boundaries





#### Grain Boundary Structure, cont'd



#### Mechanism of Grain Boundary Diffusion

#### **Vacancies and self-interstitials**



Atom jumping events in  $\Sigma$ 5<001>(310) symmetric tilt boundary in b.c.c.-Fe calculated by molecular dynamics using pair-potential model. The ratios of the scales used in the drawing are

 $[\overline{1}30]:[310]:[001]=1:1:5$ 

- vacancy trajectory, confined to grain boundary sites
  - vacancy/interstitial pair creation

#### Grain Boundaries and Impurity Diffusion

- Diffusivity of Zn along the tilt axes [110] symmetric tilt boundaries in Al as a function of tilt angle, θ.
- Orientations near the center of the plot, where the boundary diffusivity is small, correspond to orientations with a high density of coincidence sites.
   Peaks in the plot are orientations corresponding to general boundaries with more open structure.

Figure removed due to copyright restrictions.

See Figure 9.2 in Balluffi, Robert W., Samuel M. Allen, and W.Craig Carter. *Kinetics of Materials*. Hoboken, NJ: J. Wiley & Sons, 2005. ISBN: 0471246891.

### Diffusion on Stationary G.B.s

Diffusing species initially coats top surface...

A regime <u>a</u>ll material

B regimeFigure removed due to copyright restrictions.boundary regionSee Figure 9.4 in Balluffi, Robert W., Samuel M. Allen, and W. Craig Carter.*Kinetics of Materials.* Hoboken, NJ: J. Wiley & Sons, 2005. ISBN: 0471246891.

*C* regime <u>c</u>ore only

# Grain Boundary Diffusion, cont'd Regime A: Characteristic diffusion distance in bulk > grain size s.

Figure removed due to copyright restrictions. See Figure 9.4 in Balluffi, Robert W., Samuel M. Allen, and W. Craig Carter. *Kinetics of Materials*. Hoboken, NJ: J. Wiley & Sons, 2005. ISBN: 0471246891.

Fraction of atomic sites in grain boundaries is  $\eta \approx 3\delta/s$ 

Effective mean squared displacement is

$$\langle D \rangle t = D^{XL} (1 - \eta) t + D^B \eta t$$

and for  $\eta \ll 1$ ,  $\langle D \rangle = D^{XL} + (3\delta/s)D^B$ 

#### Grain Boundary Diffusion, cont'd

**Case C**: Characteristic diffusion distance in bulk < atomic spacing < characteristic diffusion distance in grain boundary.

 a diffusing atom visits only the grain boundaries

Figure removed due to copyright restrictions.

See Figure 9.4 in Balluffi, Robert W., Samuel M. Allen, and W. Craig Carter. *Kinetics of Materials*. Hoboken, NJ: J. Wiley & Sons, 2005. ISBN: 0471246891.

Case B: Intermediate regime where

 $\lambda^2 < D^{XL} t < s^2$ 

• a diffusing atom visits only a single grain

#### B-Type Diffusion, Stationary g.b.s



Solve two-dimensional diffusion problem for fast boundary diffusion and relatively slow bulk diffusion, with constant concentration of diffusant at the surface as illustrated.

$$c^{XL}(x_1, y_1, t_1) = \exp\left[-\left(\frac{4}{\pi t_1}\right)^{1/4} y_1\right] \left[1 - \operatorname{erf}\left(\frac{x_1}{2\sqrt{t_1}}\right)\right]$$

#### B-Type Diffusion, Stationary g.b.s

$$c^{XL}(x_1, y_1, t_1) = \exp\left[-\left(\frac{4}{\pi t_1}\right)^{1/4} y_1\right] \left[1 - \operatorname{erf}\left(\frac{x_1}{2\sqrt{t_1}}\right)\right]$$

Figure removed due to copyright restrictions.

See Figure 9.8 in Balluffi, Robert W., Samuel M. Allen, and W. Craig Carter. *Kinetics of Materials*. Hoboken, NJ: J. Wiley & Sons, 2005. ISBN: 0471246891.

#### Moving Grain-Boundary Diffusion Source



Steady-state diffusion with respect to a frame at the interface migrating at velocity *v* :

$$-\nabla \cdot \vec{J} = -\frac{d}{dx} \left( -D^{XL} \frac{dc}{dx} - vc \right) = 0$$

which has the solution

$$c(x) = c_0 \exp\left[\left(-v/D^{XL}\right)x\right]$$

#### Phenomena Involving Short Circuits...

Chiang, Birnie, and Kingery *Physical Ceramics*, 1997 Section 5.3 on "Single-Phase Sintering"

R W Balluffi and A Sutton, *Interfaces in Crystalline Materials*, 1995, p. 762–763 explains theory of Coble creep

Nieh, Wadsworth, and Sherby, *Superplasticity in Metals and Ceramics*, Cambridge University Press, 1997. Chapter 3 provides an overview of mechanisms of superplasticity